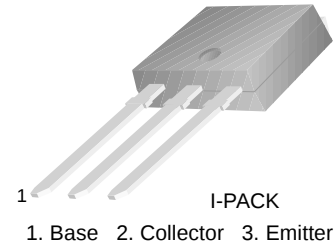


# KSD1221

KSD1221

## Low Frequency Power Amplifier

- Low Collector-Emitter Saturation Voltage
- Complement to KSB906



## NPN Epitaxial Silicon Transistor

### Absolute Maximum Ratings $T_C=25^\circ\text{C}$ unless otherwise noted

| Symbol    | Parameter                                        | Value      | Units            |
|-----------|--------------------------------------------------|------------|------------------|
| $V_{CBO}$ | Collector-Base Voltage                           | 60         | V                |
| $V_{CEO}$ | Collector-Emitter Voltage                        | 60         | V                |
| $V_{EBO}$ | Emitter-Base Voltage                             | 7          | V                |
| $I_C$     | Collector Current                                | 3          | A                |
| $I_B$     | Base Current                                     | 0.5        | A                |
| $P_C$     | Collector Dissipation ( $T_C=25^\circ\text{C}$ ) | 20         | W                |
| $P_C$     | Collector Dissipation ( $T_a=25^\circ\text{C}$ ) | 1          | W                |
| $T_J$     | Junction Temperature                             | 150        | $^\circ\text{C}$ |
| $T_{STG}$ | Storage Temperature                              | - 55 ~ 150 | $^\circ\text{C}$ |

### Electrical Characteristics $T_C=25^\circ\text{C}$ unless otherwise noted

| Symbol                 | Parameter                            | Test Condition                                                                                    | Min.     | Typ. | Max. | Units         |
|------------------------|--------------------------------------|---------------------------------------------------------------------------------------------------|----------|------|------|---------------|
| $BV_{CEO}$             | Collector-Emitter Breakdown Voltage  | $I_C = 50\text{mA}$ , $I_B = 0$                                                                   | 60       |      |      | V             |
| $I_{CBO}$              | Collector Cut-off Current            | $V_{CB} = 60\text{V}$ , $I_E = 0$                                                                 |          |      | 100  | $\mu\text{A}$ |
| $I_{EBO}$              | Emitter Cut-off Current              | $V_{EB} = 7\text{V}$ , $I_C = 0$                                                                  |          |      | 100  | $\mu\text{A}$ |
| $h_{FE1}$<br>$h_{FE2}$ | DC Current Gain                      | $V_{CE} = 5\text{V}$ , $I_C = 0.5\text{A}$<br>$V_{CE} = 5\text{V}$ , $I_C = 3\text{A}$            | 60<br>20 |      | 300  |               |
| $V_{CE(sat)}$          | Collector-Emitter Saturation Voltage | $I_C = 3\text{A}$ , $I_B = 0.3\text{A}$                                                           |          | 0.4  | 1    | V             |
| $V_{BE(on)}$           | Base-Emitter ON Voltage              | $I_C = 5\text{A}$ , $I_C = 0.5\text{A}$                                                           |          | 0.7  | 1    | V             |
| $f_T$                  | Current Gain Bandwidth Product       | $V_{CE} = 5\text{V}$ , $I_C = 0.5\text{A}$                                                        |          | 3    |      | MHz           |
| $C_{ob}$               | Output Capacitance                   | $V_{CB} = 10\text{V}$ , $f = 1\text{MHz}$                                                         |          | 70   |      | pF            |
| $t_{ON}$               | Turn ON Time                         | $V_{CC} = 30\text{V}$ , $I_C = 1\text{A}$<br>$I_{B1} = -I_{B2} = 0.2\text{A}$<br>$R_L = 30\Omega$ |          | 0.8  |      | $\mu\text{s}$ |
| $t_{STG}$              | Storage Time                         |                                                                                                   |          | 1.5  |      | $\mu\text{s}$ |
| $t_F$                  | Fall Time                            |                                                                                                   |          | 0.8  |      | $\mu\text{s}$ |

## $h_{FE}$ Classification

| Classification | O        | Y         | G         |
|----------------|----------|-----------|-----------|
| $h_{FE1}$      | 60 ~ 120 | 100 ~ 200 | 150 ~ 300 |

# Typical Characteristics

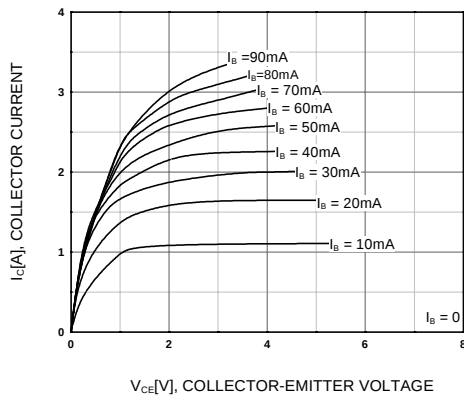


Figure 1. Static Characteristic

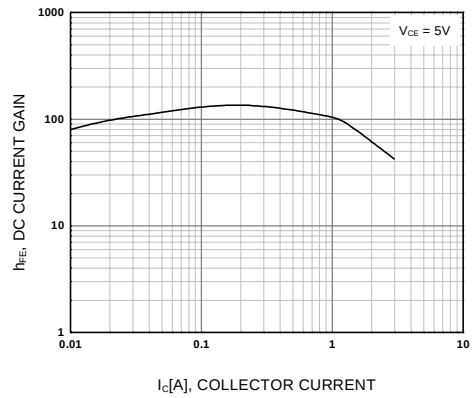


Figure 2. DC current Gain

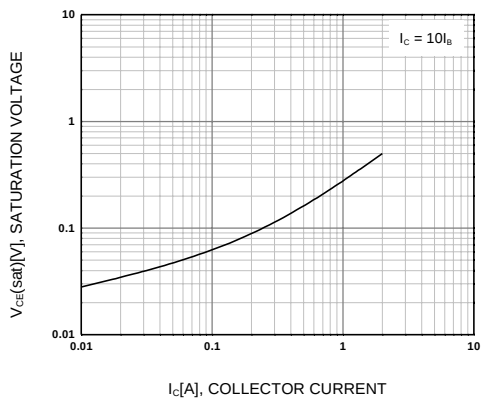


Figure 3. Collector-Emitter Saturation Voltage

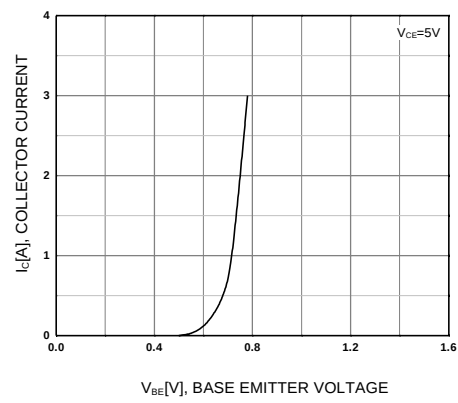


Figure 4. Base-Emitter On Voltage

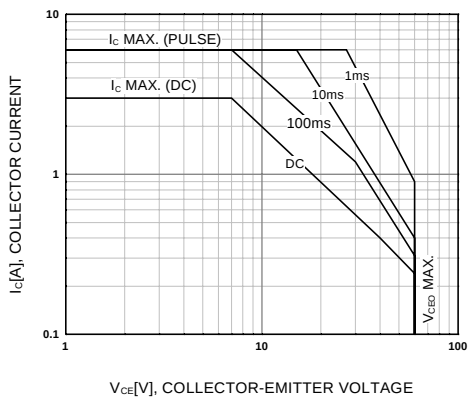


Figure 5. Safe Operating Area

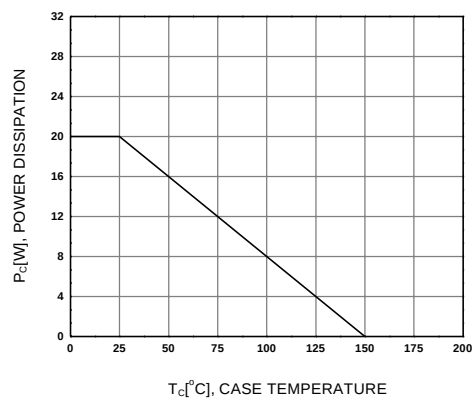
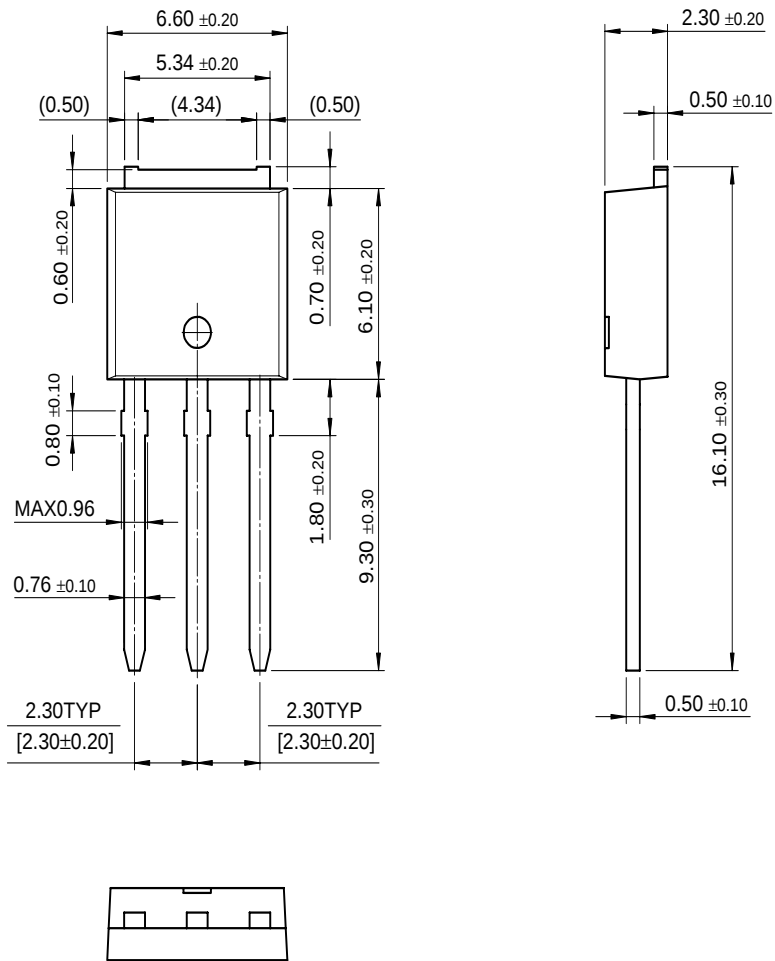


Figure 6. Power Derating

# Package Dimensions

## I-PAK



Dimensions in Millimeters

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